Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10517948	HEISE ET AL.
Examiner	Art Unit
Chen, Xiaoliang	2841

SEARCHED					
Class	Subclass	Date	Examiner		
361	104, 760-763, 833, 834	05-17-07	xc		
174	250, 261	05-17-07	xc		
337	227, 290-297	05-17-07	xc		

SEARCH NOTES				
Search Notes	Date	Examiner		
Puls, Inventor,	05-16-07	XC		
EAST / Ref Proir Art, Foreward/Backward, USPAT, PGPUB, DERWENT, IBM-TDB, ITIC-On line, IEEE Xplore and text	05-16-07	xc		
onsulted Tuan DinhC	05-16-07	xc		

	INTERFERENCE SEARCH				
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